

● General Description

The HM20DN04D combines advanced trench MOSFET technology with a low resistance package to provide extremely low RDS(ON). This device is ideal for load switch and battery protection applications.

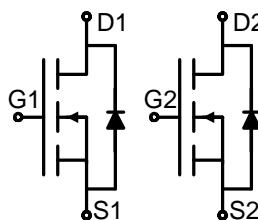
● Features

- Advance high cell density Trench technology
- Low RDS(ON) to minimize conductive loss
- Low Gate Charge for fast switching
- Dual DIE in one package

● Application

- Power Management in Notebook Computer,
- Portable Equipment and Battery
- Powered Systems

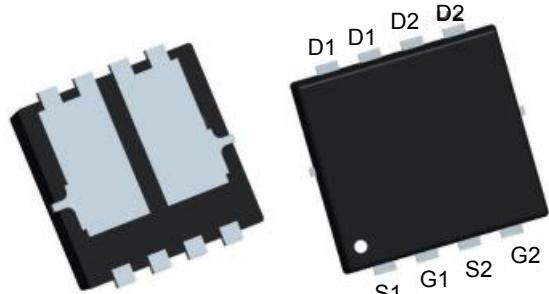
● Product Summary



$V_{DS} = 40V$

$R_{DS(ON)} = 13m\Omega$

$I_D = 20A$



PDFNWB5x6-8L

● Package Marking and Ordering Information:

Part NO.	HM20DN04D
Marking	D130N04N
Packing Information	---
Basic ordering unit (pcs)	5000

● Absolute Maximum Ratings ($T_C = 25^\circ C$)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	40	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	$I_D @ T_C = 25^\circ C$	20	A
	$I_D @ T_C = 75^\circ C$	15	A
	$I_D @ T_C = 100^\circ C$	12	A
Pulsed Drain Current ①	I_{DM}	50	A
Total Power Dissipation	$P_D @ T_C = 25^\circ C$	45	W
Total Power Dissipation	$P_D @ T_A = 25^\circ C$	1.5	W
Operating Junction Temperature	T_J	-55 to 150	$^\circ C$
Storage Temperature	T_{STG}	-55 to 150	$^\circ C$
Single Pulse Avalanche Energy	E_{AS}	50	mJ

•Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R _{thJC}	-	-	2.5	° C/W
Thermal resistance, junction - ambient	R _{thJA}	-	-	75	° C/W
Soldering temperature, wavesoldering for 8 s	T _{sold}	-	-	265	° C

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250uA	40	-	-	V
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} =V _{DS} , I _D =250uA	1.2	1.5	2.5	V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =40 V _{GS} =0V	-	-	1.0	uA
Gate- Source Leakage Current	I _{GSS}	V _{GS} =±20V ,V _{DS} =0V	-	-	±100	nA
Static Drain-source On Resistance	R _{DS(ON)}	V _{GS} =10V, I _D =12A	-	13	15	mΩ
		V _{GS} =4.5V, I _D =8A	-	16	18	mΩ
Forward Transconductance	g _{FS}	V _{DS} =25V, I _D =10A	-	8	-	S
Source-drain voltage	V _{SD}	I _S =10A	-	-	1.20	V

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Input capacitance	C _{iss}	f = 1MHz V _{DS} =20V V _{GS} =0V	-	1137	-	pF
Output capacitance	C _{oss}		-	84	-	
Reverse transfer capacitance	C _{rss}		-	72	-	

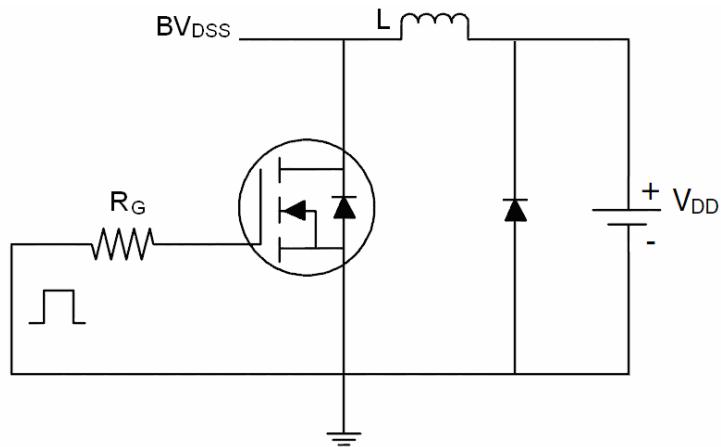
•Gate Charge characteristics(T_a = 25°C)

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Total gate charge	Q _g	V _{DD} = 20V I _D = 8A V _{GS} = 10V	-	25	-	nC
Gate - Source charge	Q _{gs}		-	3.6	-	
Gate - Drain charge	Q _{gd}		-	4.4	-	

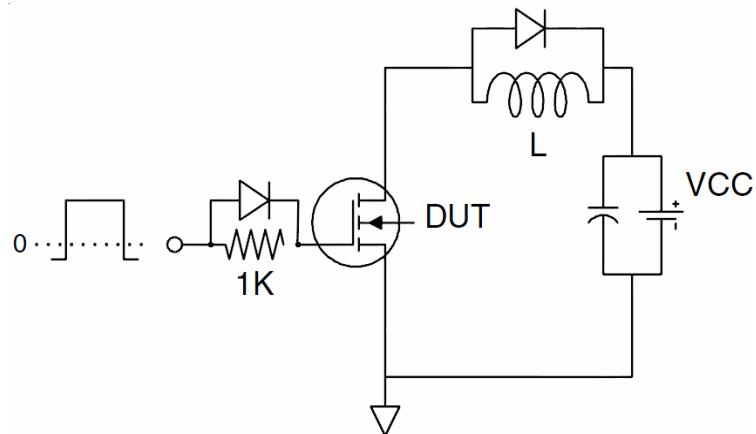
Note: ① Pulse Test : Pulse width ≤ 300μs, Duty cycle ≤ 2% ;

Test Circuit

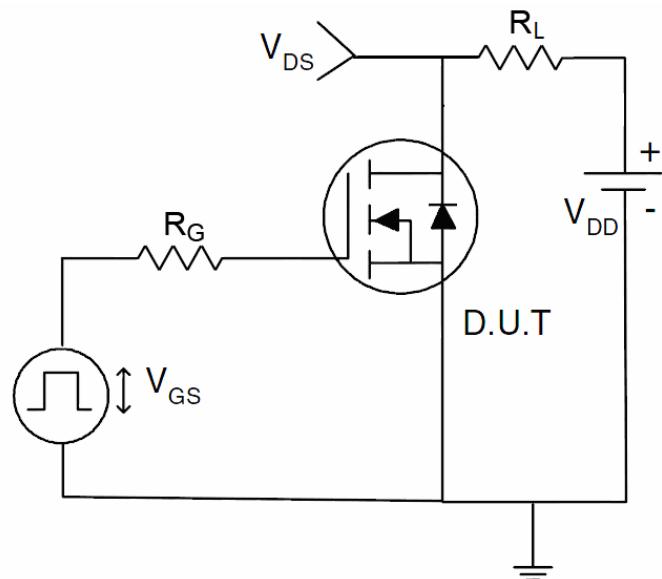
1) E_{AS} test Circuit



2) Gate charge test Circuit



3) Switch Time Test Circuit



Typical Electrical and Thermal Characteristics

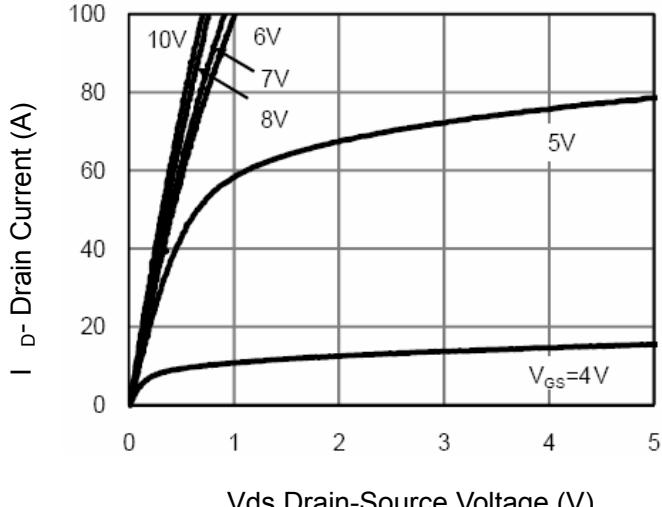


Figure 1 Output Characteristics

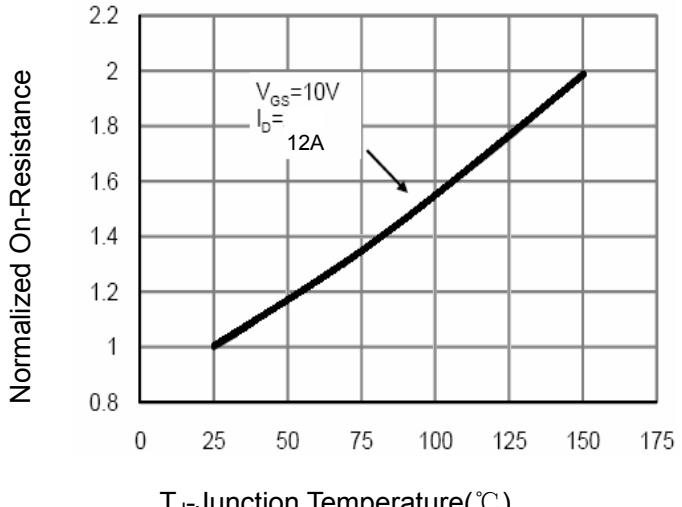


Figure 4 Rdson-JunctionTemperature

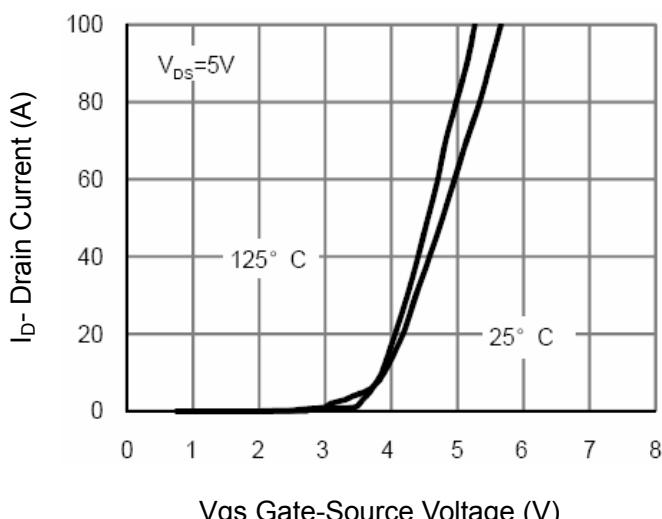


Figure 2 Transfer Characteristics

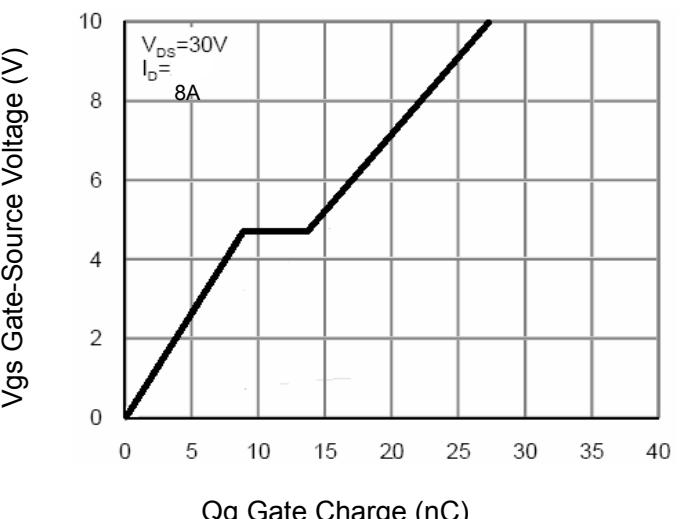


Figure 5 Gate Charge

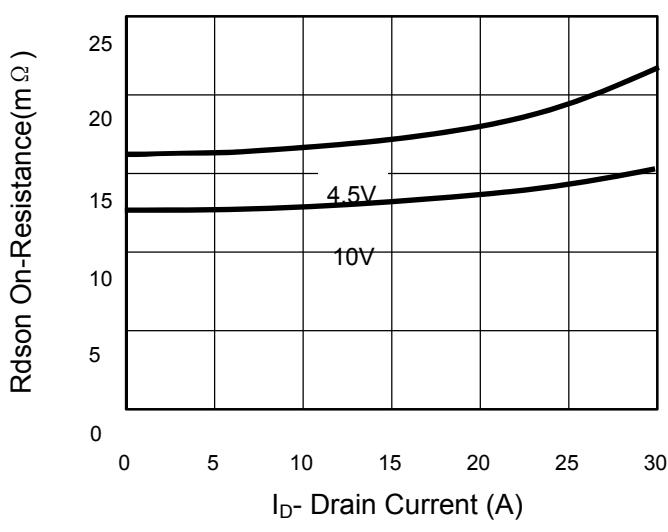


Figure 3 Rdson- Drain Current

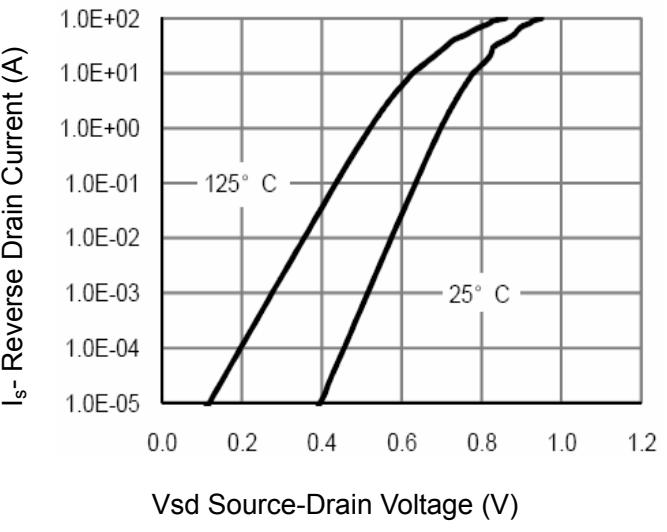


Figure 6 Source- Drain Diode Forward

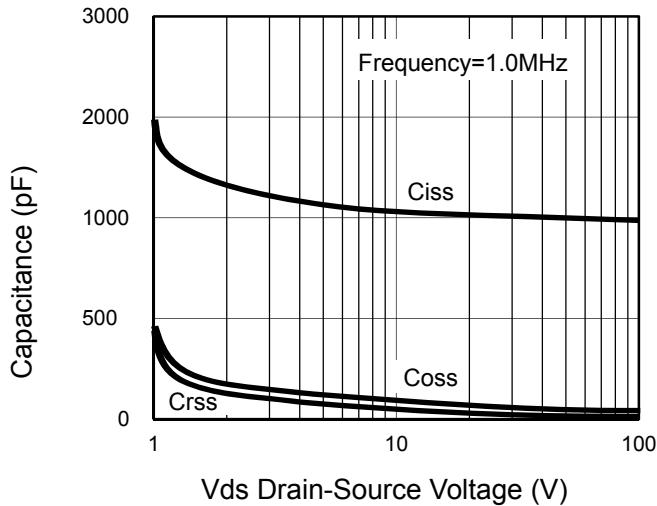


Figure 7 Capacitance vs Vds

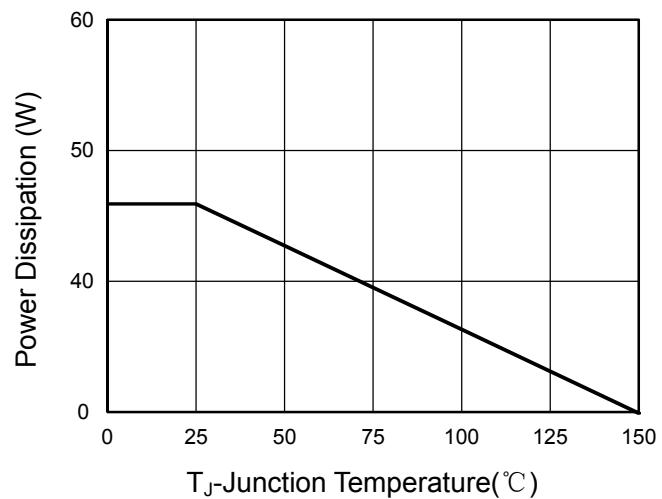


Figure 9 Power De-rating

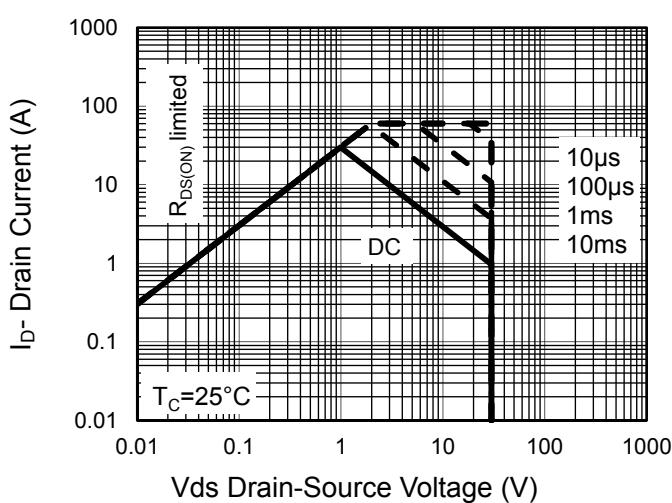


Figure 8 Safe Operation Area

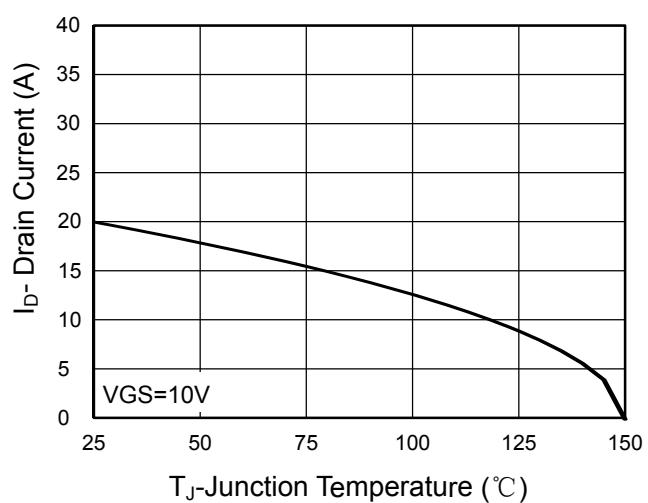


Figure 10 Current De-rating

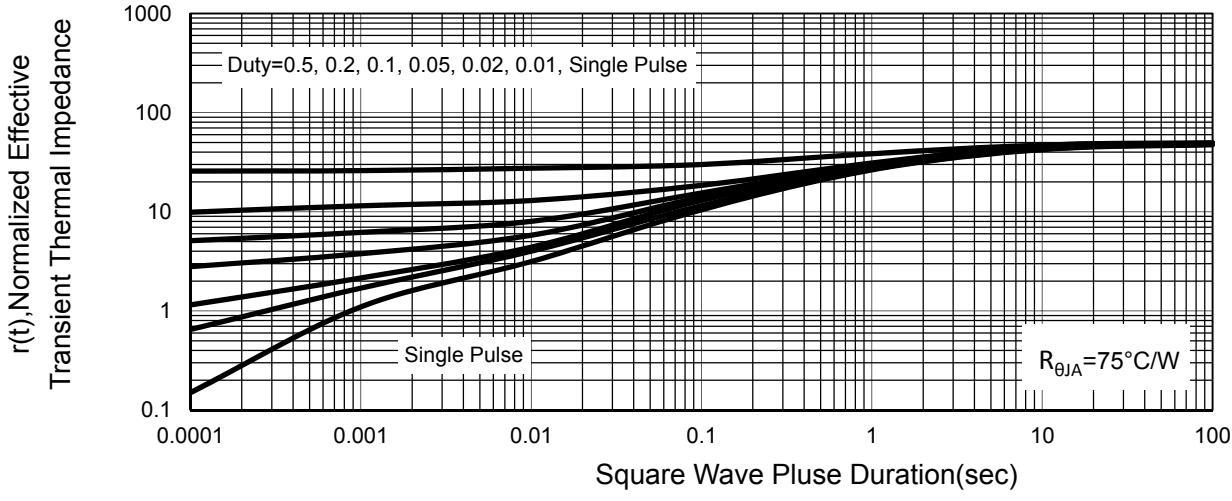
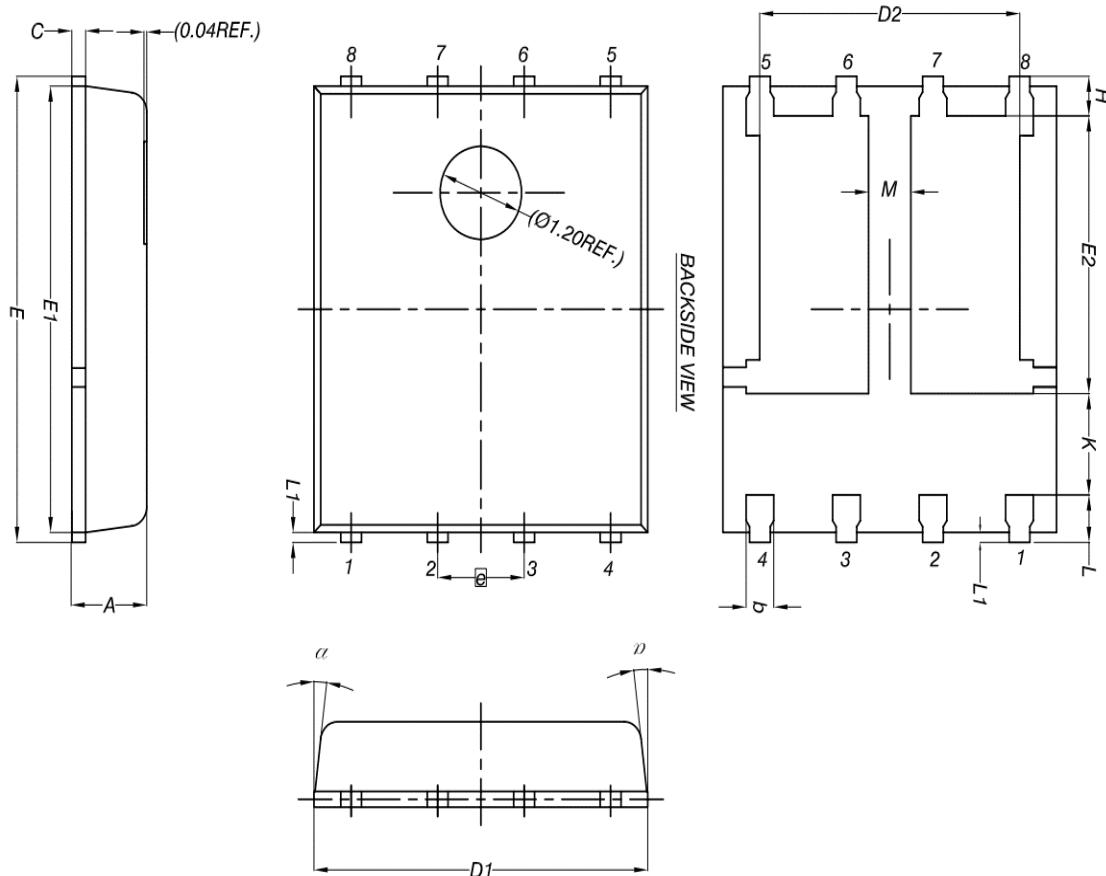


Figure 11 Normalized Maximum Transient Thermal Impedance

PDFNWB5x6-8L Package Outline Dimensions



Symbol	DIMENSIONS (unit : mm)		
	Min	Typ	Max
A	0.9	1	1.1
b	0.33	0.41	0.51
C	0.2	0.25	0.3
D1	4.8	4.9	5
D2	3.61	3.81	3.96
E	5.9	6	6.1
E1	5.7	5.75	5.8
E2	3.38	3.58	3.78
e	1.27 BSC		
H	0.41	0.51	0.61
K	1.1	--	--
L	0.51	0.61	0.71
L1	0.06	0.13	0.2
M	0.5	--	--
α	0°	--	12°

Note:

1. Controlling dimension:in millimeters.
2. General tolerance: ± 0.05 mm.
3. The pad layout is for reference purposes only.